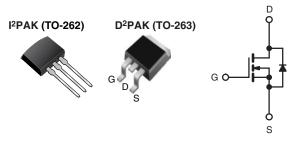


Vishay Siliconix

### **Power MOSFET**

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	60			
$R_{DS(on)}\left(\Omega\right)$	$V_{GS} = 5 V$	0.20		
Q <sub>g</sub> (Max.) (nC)	8.4			
Q <sub>gs</sub> (nC)	3.5			
Q <sub>gd</sub> (nC)	6.0			
Configuration	Single			



N-Channel MOSFET

#### **FEATURES**

- Advanced Process Technology
- Surface Mount (IRLZ14S/SiHLZ14S)
- Low-Profile Through-Hole (IRLZ14L/SiHLZ14L)
- 175 °C Operating Temperature
- · Fast Switching
- Lead (Pb)-free Available

### **DESCRIPTION**

Third generation Power MOSFETs from Vishay utilize advanced processing techniques to achieve extermely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that Power MOSFETs are well known for, provides the designer with an extremely efficient reliable device for use in a wide variety of applications.

The D<sup>2</sup>PAK is a surface mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and lowest possible on-resistance in any existing surface mount package. The D<sup>2</sup>PAK is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0 W in a typical surface mount application.

The through-hole version (IRLZ44L/SiHLZ44L) is available for low-profile applications.

ORDERING INFORMATION				
Package	D <sup>2</sup> PAK (TO-263)	D <sup>2</sup> PAK (TO-263)	I <sup>2</sup> PAK (TO-262)	
Lead (Pb)-free	IRLZ14SPbF	IRLZ14STRRPbFa	-	
Lead (Fb)-liee	SiHLZ14S-E3	SiHLZ14STR-E3 <sup>a</sup>	-	
SnPb	IRLZ14S	IRLZ14TRR <sup>a</sup>	IRLZ14L	
SIFD	SiHLZ14S	SiHLZ14TR <sup>a</sup>	SiHLZ14L	

#### Note

a. See device orientation.

<b>ABSOLUTE MAXIMUM RATINGS</b> $T_C = 25$ °C, unless otherwise noted						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage <sup>e</sup>			$V_{DS}$	60		
Gate-Source Voltage			$V_{GS}$	± 10	V	
Continuous Drain Current	\/ at F \/	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$	- I <sub>D</sub>	10		
	V <sub>GS</sub> at 5 V	T <sub>C</sub> = 100 °C		7.2	Α	
Pulsed Drain Current <sup>a, e</sup>			I <sub>DM</sub>	40		
Linear Derating Factor				0.29	W/°C	
Single Pulse Avalanche Energy <sup>b, e</sup>			E <sub>AS</sub>	68	mJ	
Maximum Power Dissipation	T <sub>C</sub> = 25 °C		Б	43	10/	
	T <sub>A</sub> = 25 °C		$P_{D}$	3.7	W	
Peak Diode Recovery dV/dtc, e	ak Diode Recovery dV/dt <sup>c, e</sup>		dV/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub> - 55 to + 175		00		
Soldering Recommendations (Peak Temperature)	for	10 s		300 <sup>d</sup>	- °C	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD}=25$  V, starting  $T_J=25$  °C, L=790  $\mu H$ ,  $R_G=25$   $\Omega$ ,  $I_{AS}=10$  A (see fig. 12).
- c.  $I_{SD} \le 10$  A,  $dI/dt \le 90$  A/ $\mu$ s,  $V_{DD} \le V_{DS}$ ,  $T_J \le 175$  °C.
- 1.6 mm from case.
- e. Uses IRLZ14/SiHLZ14 data and test conditions.
- \* Pb containing terminations are not RoHS compliant, exemptions may apply

# IRLZ14S, IRLZ14L, SiHLZ14S, SiHLZ14L

# Vishay Siliconix



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient (PCB Mount) <sup>a</sup>	R <sub>thJA</sub>	-	40	°C/W		
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	3.5			

#### Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT		
Static						•	•	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		60	-	-	V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, I <sub>D</sub> = 1 mA		0.07	-	V/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	· V <sub>GS</sub> , I <sub>D</sub> = 250 μA	1.0	-	2.0	٧	
Gate-Source Leakage	I <sub>GSS</sub>	,	V <sub>GS</sub> = ± 10 V	-	-	± 100	nA	
		V <sub>DS</sub> :	V <sub>DS</sub> = 60 V, V <sub>GS</sub> = 0 V		-	25		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 48 V	V <sub>GS</sub> = 0 V, T <sub>J</sub> = 150 °C	-	-	250	μΑ	
Durin Occurs Oc Olda Basistana	Б	V <sub>GS</sub> = 5 V	I <sub>D</sub> = 6.0 A <sup>b</sup>	-	-	0.2		
Drain-Source On-State Resistance	hin-Source On-State Resistance $R_{DS(on)}$ $V_{GS} = 4 \text{ V}$ $I_D = 5.0$	I <sub>D</sub> = 5.0 A <sup>b</sup>	-	-	0.28	Ω		
Forward Transconductance	9 <sub>fs</sub>	$V_{DS} = 25 \text{ V}, I_{D} = 6.0 \text{ A}$		3.5	-	-	S	
Dynamic								
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$		-	400	-	pF	
Output Capacitance	C <sub>oss</sub>			-	170	-		
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.	f = 1.0 MHz, see fig. 5		42	-		
Total Gate Charge	Qg			-	-	8.4	nC	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 5 V	$I_D = 10 \text{ A}, V_{DS} = 48 \text{ V},$ see fig. 6 and 13 <sup>b</sup>	-	-	3.5		
Gate-Drain Charge	Q <sub>gd</sub>	7	goo ng. o ana 10	-	-	6.0		
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{DD} = 30 \text{ V}, I_{D} = 10 \text{ A},$ $R_{G} = 12 \Omega, R_{D} = 2.8 \Omega, \text{ see fig. } 10^{b}$		-	9.3	-	- ns	
Rise Time	t <sub>r</sub>			-	110	-		
Turn-Off Delay Time	t <sub>d(off)</sub>			-	17	-		
Fall Time	t <sub>f</sub>			-	26	-		
Internal Source Inductance	L <sub>S</sub>	Between lead, and center of die contact		-	7.5	-	nH	
Drain-Source Body Diode Characteristic	s							
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET sym showing the	MOSFET symbol showing the		-	10	۸	
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	integral reverse p - n junction diode		-	-	40	A	
Body Diode Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C	$T_J = 25  ^{\circ}\text{C},  I_S = 10  \text{A},  V_{GS} = 0  \text{V}^{\text{b}}$		-	1.6	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T 05 00 1	T 0500 L 10 L 11/1 155 L		93	130	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	$T_J = 25  ^{\circ}\text{C}, \ I_F = 10  \text{A}, \ \text{dI/dt} = 100  \text{A/}\mu\text{s}^{\text{b}}$		-	340	650	nC	
Forward Turn-On Time	t <sub>on</sub>	Intrinsic tu	on is don	ninated b	y L <sub>S</sub> and I	 L <sub>D</sub> )		

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq 300~\mu s;$  duty cycle  $\leq 2~\%.$



### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

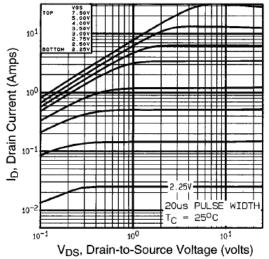


Fig. 1 - Typical Output Characteristics

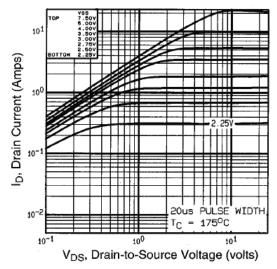


Fig. 2 - Typical Output Characteristics

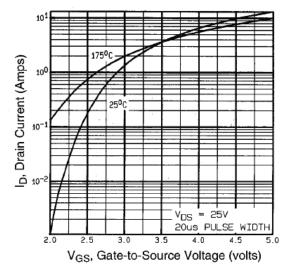


Fig. 3 - Typical Transfer Characteristics

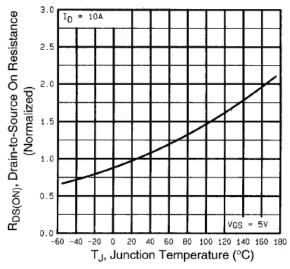


Fig. 4 - Normalized On-Resistance vs. Temperature

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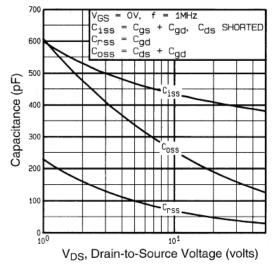


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

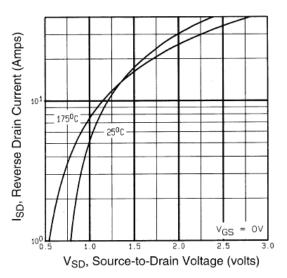


Fig. 7 - Typical Source-Drain Diode Forward Voltage

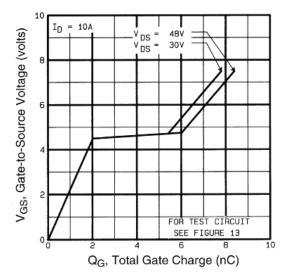


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

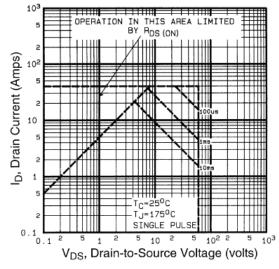


Fig. 8 - Maximum Safe Operating Area





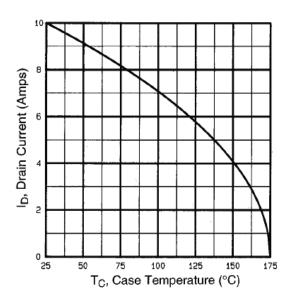


Fig. 9 - Maximum Drain Current vs. Case Temperature

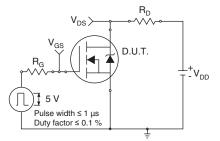


Fig. 10a - Switching Time Test Circuit

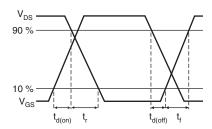


Fig. 10b - Switching Time Waveforms

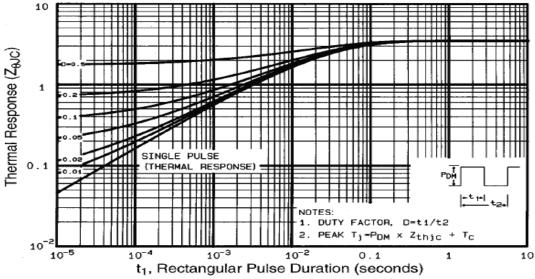
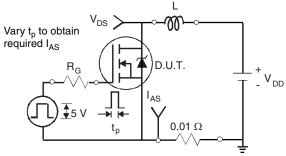


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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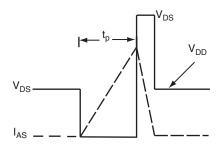


Fig. 12b - Unclamped Inductive Waveforms

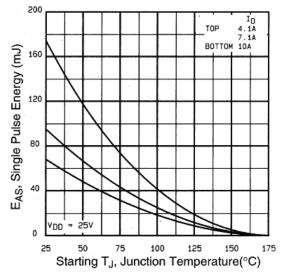


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

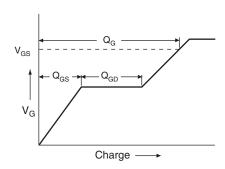


Fig. 13a - Basic Gate Charge Waveform

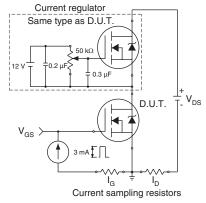
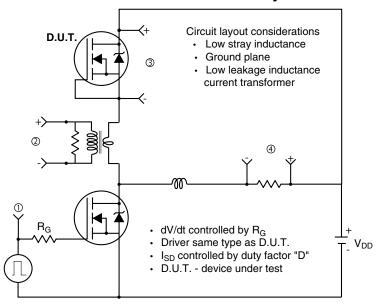
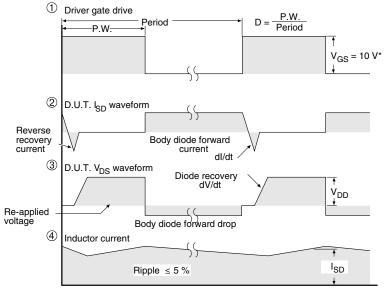


Fig. 13b - Gate Charge Test Circuit



### Peak Diode Recovery dV/dt Test Circuit





\*  $V_{GS} = 5 V$  for logic level devices

Fig. 14 - For N-Channel

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Vishay

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Revision: 18-Jul-08

Document Number: 91000 www.vishay.com